



#### COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

#### **Product Summary**

Device	V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub>	I <sub>D</sub> T <sub>A</sub> = +25°C
Q1	20V	0.45Ω @ V <sub>GS</sub> = 4.5V	1066mA
Q2	200	0.75Ω @ V <sub>GS</sub> = -4.5V	-845mA

#### **Description**

This new generation MOSFET has been designed to minimize the onstate resistance (RDS(on)) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

### **Applications**

- Battery Operated Systems and Solid-State Relays
- Drivers: Relays, Solenoids, Lamps, Hammers, Displays, Memories, Transistors, etc.
- Power Supply Converter Circuits

#### **Features and Benefits**

- Low On-Resistance
- Low Gate Threshold Voltage
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Complementary Pair MOSFET
- Ultra-Small Surface Mount Package
- ESD Protected Up to 2.5kV
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 standards for High Reliability

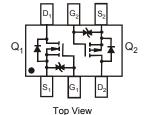
#### **Mechanical Data**

- Case: SOT363
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Matte Tin Finish annealed over Alloy 42 leadframe (Lead Free Plating). Solderable per MIL-STD-202, Method 208 @3)
- Terminal Connections: See Diagram
- Weight: 0.006 grams (approximate)









Internal Schematic

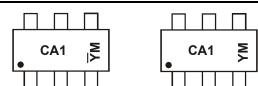
### Ordering Information (Note 4)

Part Number	Compliance	Case	Packaging	
DMG1016UDW-7	Standard	SOT363	3000/Tape & Reel	
DMG1016UDWQ-7	Automotive	SOT363	3000/Tape & Reel	

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead\_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green"
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain < 900ppm bromine, < 900ppm chlorine (< 1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

## **Marking Information**



CA1 = Product Type Marking Code

YM = Date Code Marking for SAT (Shanghai Assembly/ Test site) YM = Date Code Marking for CAT (Chengdu Assembly/ Test site)

Y or  $\overline{Y}$  = Year (ex: A = 2013)

M = Month (ex: 9 = September)

Date	Code	Ke

Date Code Ke	<del>≥</del> y											
Year	2008	20	09	2010	2011	20	12	2013	2014	20	015	2016
Code	V	١	N	Χ	Υ		Z	Α	В		С	D
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	1	5	6	7	8	Q	0	N	D



# Thermal Characteristics (@TA = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units
Total Power Dissipation (Note 5)	P <sub>D</sub>	330	mW
Thermal Resistance, Junction to Ambient (Note 5)	$R_{ hetaJA}$	379	°C/W
Operating and Storage Temperature Range	T <sub>J,</sub> T <sub>STG</sub>	-55 to +150	°C

## Maximum Ratings N-CHANNEL – Q1 (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Units
Drain-Source Voltage	$V_{DSS}$	20	V	
Gate-Source Voltage	$V_{GSS}$	±6	V	
Continuous Drain Current (Note 5)		I <sub>D</sub>	1066 690	mA

## Maximum Ratings P-CHANNEL – Q2 (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Units	
Drain-Source Voltage			$V_{DSS}$	-20	V
Gate-Source Voltage	V <sub>GSS</sub>	±6	V		
Continuous Drain Current (Note 5)		I <sub>D</sub>	-845 -548	mA	

## Electrical Characteristics N-CHANNEL - Q1 (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 6)	•					•	
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	20	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current @T <sub>C</sub> =	: +25°C I <sub>DSS</sub>	_	_	100	nA	V <sub>DS</sub> =20V, V <sub>GS</sub> = 0V	
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±1.0	μA	$V_{GS} = \pm 4.5 V, V_{DS} = 0 V$	
ON CHARACTERISTICS (Note 6)							
Gate Threshold Voltage	V <sub>GS(th)</sub>	0.5	_	1.0	V	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$	
		_	0.3	0.45		$V_{GS} = 4.5V$ , $I_D = 600$ mA	
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>		0.4	0.6	Ω	$V_{GS}$ = 2.5V, $I_{D}$ = 500mA	
			0.5	0.75		V <sub>GS</sub> = 1.8V, I <sub>D</sub> = 350mA	
Forward Transfer Admittance		_	1.4	_	S	V <sub>DS</sub> = 10V, I <sub>D</sub> = 400mA	
Diode Forward Voltage (Note 6)		_	0.7	1.2	V	V <sub>GS</sub> = 0V, I <sub>S</sub> = 150mA	
DYNAMIC CHARACTERISTICS (Note 7)				_			
Input Capacitance	C <sub>iss</sub>	_	60.67	_	pF	.,,	
Output Capacitance	Coss	_	9.68	_	pF	$V_{DS} = 10V, V_{GS} = 0V,$ f = 1.0MHz	
Reverse Transfer Capacitance	$C_{rss}$	_	5.37	_	pF	1 - 1.000112	
Total Gate Charge (4.5V)	Qg	_	736.6	_	nC		
Gate-Source Charge		_	93.6	_	nC	$V_{GS} = 4.5V, V_{DS} = 10V,$ $I_D = 250 \text{mA}$	
Gate-Drain Charge	$Q_{gd}$	_	116.6	_	nC	IID - ZOUTIA	
Turn-On Delay Time		_	5.1	_	ns		
Turn-On Rise Time		_	7.4	_	ns	V <sub>DD</sub> = 10V, V <sub>GS</sub> = 4.5V,	
Turn-Off Delay Time	t <sub>D(off)</sub>	_	26.7	_	ns	$R_L = 47\Omega$ , $R_G = 10\Omega$ ,	
Turn-Off Fall Time	t <sub>f</sub>	_	12.3	_	ns		

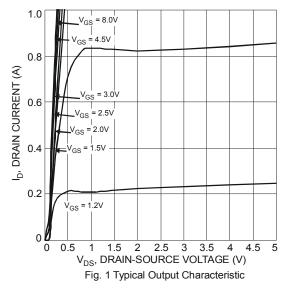
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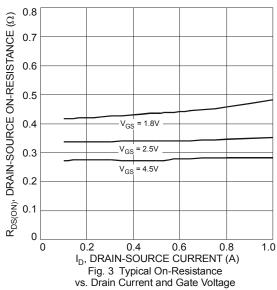
<sup>5.</sup> Device mounted on FR-4 PCB with minimum recommended pad layout. 6. Short duration pulse test used to minimize self-heating effect.

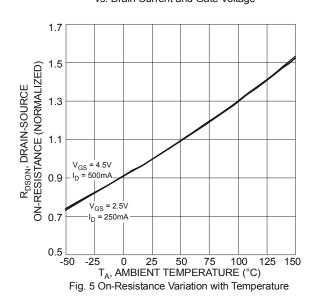
<sup>7.</sup> Guaranteed by design. Not subject to production testing.

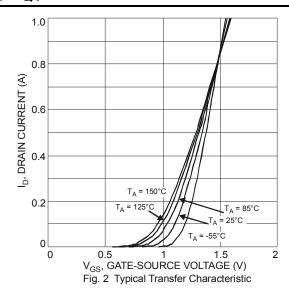


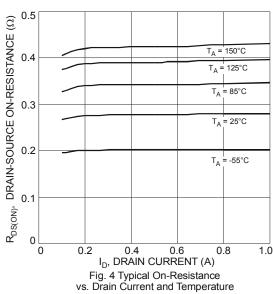
### N-CHANNEL - Q1

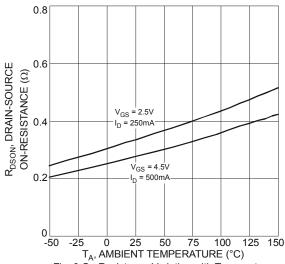














## N-CHANNEL - Q1 (cont.)

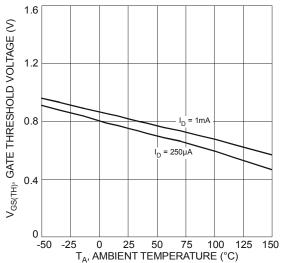
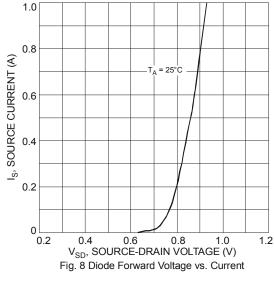
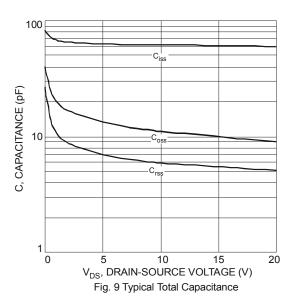


Fig. 7 Gate Threshold Variation vs. Ambient Temperature





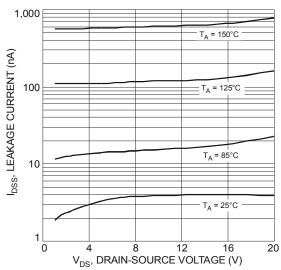


Fig. 10 Typical Leakage Current vs. Drain-Source Voltage

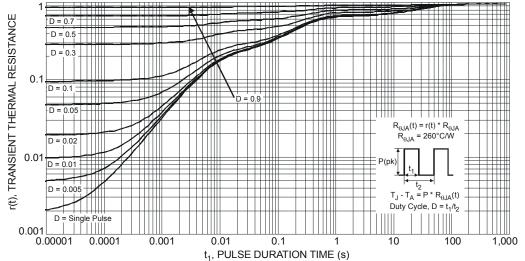


Fig. 11 Transient Thermal Response



# Electrical Characteristics P-CHANNEL – Q2 (@T<sub>A</sub> = +25°C, unless otherwise specified.)

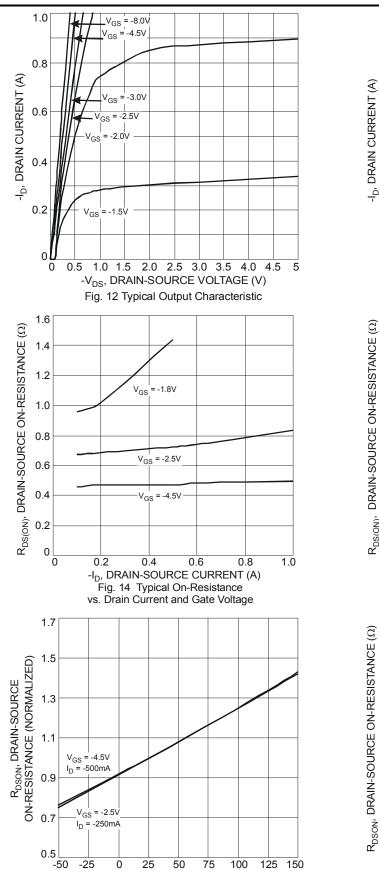
Characteristic		Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 6)							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-20	_	_	V	$V_{GS} = 0V, I_D = -250\mu A$	
Zero Gate Voltage Drain Current @Tc = +25°C	I <sub>DSS</sub>	1	_	-100	nA	$V_{DS} = -20V, V_{GS} = 0V$	
Gate-Source Leakage	I <sub>GSS</sub>	1	_	±2.0	μΑ	$V_{GS} = \pm 4.5 V, V_{DS} = 0 V$	
ON CHARACTERISTICS (Note 6)							
Gate Threshold Voltage	V <sub>GS(th)</sub>	-0.5	_	-1.0	V	$V_{DS} = V_{GS}$ , $I_D = -250\mu A$	
		_	0.5	0.75		$V_{GS} = -4.5V$ , $I_D = -430$ mA	
Static Drain-Source On-Resistance	R <sub>DS (ON)</sub>		0.7	1.05	Ω	$V_{GS} = -2.5V$ , $I_D = -300$ mA	
			1.0	1.5		$V_{GS} = -1.8V, I_D = -150mA$	
Forward Transfer Admittance	Y <sub>fs</sub>	_	0.9	_	S	$V_{DS} = -10V, I_{D} = -250mA$	
Diode Forward Voltage (Note 6)	V <sub>SD</sub>	1	-0.8	-1.2	V	$V_{GS} = 0V, I_{S} = -150mA$	
DYNAMIC CHARACTERISTICS (Note 7)							
Input Capacitance	C <sub>iss</sub>	-	59.76	_	pF	.,	
Output Capacitance	Coss		12.07	_	pF	$V_{DS} = -16V, V_{GS} = 0V,$ f = 1.0MHz	
Reverse Transfer Capacitance	C <sub>rss</sub>		6.36	_	pF	1 - 1.00112	
Total Gate Charge (4.5V)	Qg	_	622.4	_	рC		
Gate-Source Charge	Q <sub>gs</sub>	_	100.3	_	рC	$V_{GS} = -4.5V, V_{DS} = -10V,$	
Gate-Drain Charge	Q <sub>gd</sub>	_	132.2	_	рС	I <sub>D</sub> = -250mA	
Turn-On Delay Time		_	5.1	_	ns		
Turn-On Rise Time		_	8.1	_	ns	$V_{DS} = -10V, V_{GS} = -4.5V,$	
Turn-Off Delay Time	t <sub>D(off)</sub>	_	28.4	_	ns	$R_G = 10\Omega$ , $R_L = 47\Omega$	
Turn-Off Fall Time	t <sub>f</sub>		20.72	_	ns		

Notes:

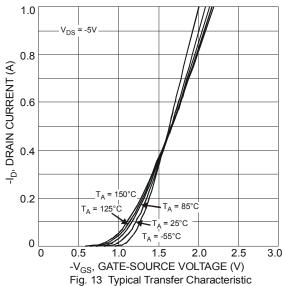
<sup>6.</sup> Short duration pulse test used to minimize self-heating effect. 7. Guaranteed by design. Not subject to production testing

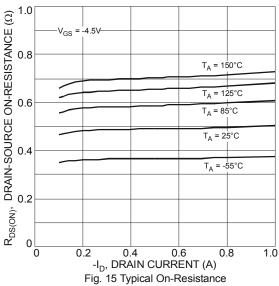


### P-CHANNEL - Q2



T<sub>A</sub>, AMBIENT TEMPERATURE (°C) Fig. 16 On-Resistance Variation with Temperature





vs. Drain Current and Temperature

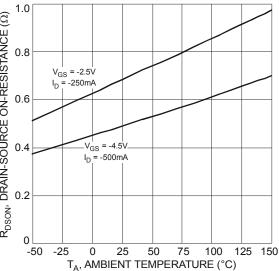


Fig. 17 On-Resistance Variation with Temperature



## P-CHANNEL - Q2 (cont.)

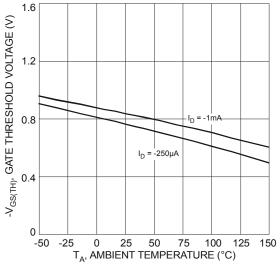
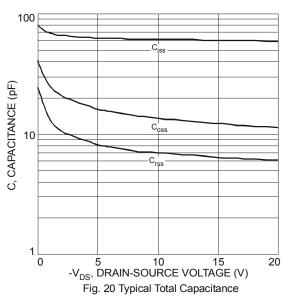
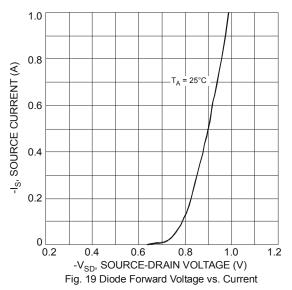
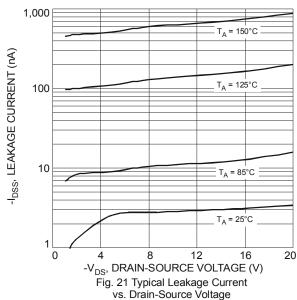
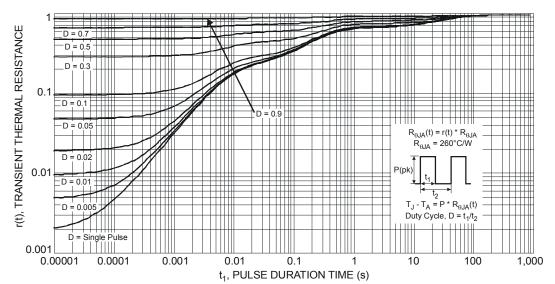


Fig. 18 Gate Threshold Variation vs. Ambient Temperature





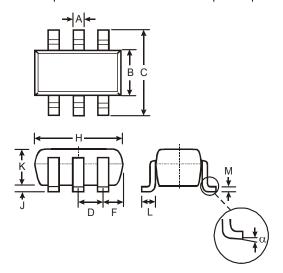






## **Package Outline Dimensions**

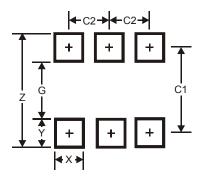
 $Please\ see\ AP02002\ at\ http://www.diodes.com/datasheets/ap02002.pdf\ for\ latest\ version.$ 



	SOT363					
Dim Min Max						
Α	0.10 0.30					
В	1.15	1.35				
C	2.00 2.20					
D	0.65 Typ					
F	0.40	0.45				
Н	1.80 2.20					
7	0 0.10					
K	0.90	1.00				
L	0.25 0.40					
M	0.10 0.22					
α 0° 8°						
All Di	mensions	in mm				

# **Suggested Pad Layout**

Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



Dimensions	Value (in mm)
Z	2.5
G	1.3
X	0.42
Y	0.6
C1	1.9
C2	0.65



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